

100V 90mohm N-channel SGT MOSFET

AKG10N900EL

Description:

This N channel SGT MOSFET has been designed to low on-state resistance and maintain superior switching performance, especial for high efficiency power management applications.

Features:

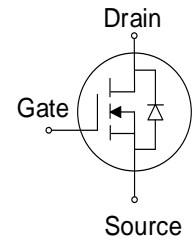
- Low $R_{DS(ON)}$
- RoHS compliant ^(Note 1)
- Halogen-free ^(Note 1)

Applications:

- Battery Management System
- Motor Drivers
- DC-DC Converter

Key Performance Parameters:

Parameter	Value	Unit
V_{DS}	100	V
$R_{DS(ON), max} @ V_{GS} = 10V$	90	m Ω
I_D	3	A



Ordering Information:

Ordering Code	Package Type	Marking Code	Form	Packing
AKG10N900EL	SOT-23-3L	10N09	Tape Reel	3000PCS

Notes:

1. Contact ALKAIDSEMI sales for detail information

Maximum Ratings ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Value	Units
V_{DS}	Drain-Source Voltage	100	V
I_D	Drain Current - Continuous ($T_C = 25^\circ\text{C}$) ^(Note 1)	3	A
	Drain Current - Continuous ($T_C = 100^\circ\text{C}$)	1.8	A
I_{DM}	Drain Current - Pulsed ^(Note 2)	12	A
V_{GS}	Gate-Source Voltage	± 20	V
E_{AS}	Single Pulsed Avalanche Energy ^(Note 3)	7.5	mJ
P_D	Power Dissipation ($T_C = 25^\circ\text{C}$)	1.3	W
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +150	$^\circ\text{C}$

Thermal Characteristics

Symbol	Parameter	Value	Units
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Steady State ^(Note 4)	95	$^\circ\text{C}/\text{W}$

Notes:

1. The max drain current rating is silicon limited
2. Repetitive Rating: Pulse width limited by maximum junction temperature
3. $L = 0.5 \text{ mH}$, $V_{DD} = 50 \text{ V}$, $I_{AS} = 5.5 \text{ A}$, $R_G = 25 \Omega$, Starting $T_J = 25 \text{ }^\circ\text{C}$
4. Mount on minimum PCB layout

Electrical Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise noted)						
Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Static Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{ V}, I_D = 250\ \mu\text{A}$	100			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 100\text{ V}, V_{GS} = 0\text{ V},$			1	μA
I_{GSS}	Gate Leakage Current	$V_{GS} = \pm 20\text{ V}, V_{DS} = 0\text{ V}$			± 100	nA
$V_{GS(TH)}$	Gate Threshold voltage	$V_{DS} = V_{GS}, I_D = 250\ \mu\text{A}$	1	2	3	V
$R_{DS(ON)}$	Drain-Source on-state resistance	$V_{GS} = 10\text{ V}, I_D = 1\text{ A}$		70	90	m Ω
		$V_{GS} = 4.5\text{ V}, I_D = 1\text{ A}$		98	130	m Ω
Dynamic Characteristics						
C_{ISS}	Input Capacitance	$V_{DS} = 50\text{ V}, V_{GS} = 0\text{ V},$ $F = 1\text{ MHz}$		230		pF
C_{OSS}	Output Capacitance			70		pF
C_{RSS}	Reverse Transfer Capacitance			8		pF
R_G	Gate Resistance	$F = 1\text{ MHz}$		1.1		Ω
Switching Characteristics						
$T_{D(ON)}$	Turn On Delay Time	$V_{DD} = 15\text{ V}, R_L = 7.5\ \Omega,$ $V_{GS} = 10\text{ V}, R_G = 6.8\ \Omega$		3		nS
T_R	Rise Time			16.5		nS
$T_{D(OFF)}$	Turn Off Delay Time			7.5		nS
T_F	Fall Time			3.5		nS
Q_G	Total Gate Charge	$V_{DD} = 50\text{ V}, I_D = 2\text{ A},$ $V_{GS} = 10\text{ V}$		5.4		nC
Q_{GS}	Gate-Source Charge			0.8		nC
Q_{GD}	Gate-Drain Charge			1.1		nC
Drain-Source Diode Characteristics and Maximum Ratings						
I_S	Maximum Continuous Body-Diode Forward Current				3	A
I_{SM}	Maximum Pulsed Body-Diode Forward Current ^(NOTE 1)				12	A
V_{SD}	Diode Forward Voltage	$V_{GS} = 0\text{ V}, I_S = 1\text{ A}$		0.82		V
T_{RR}	Reverse recovery time	$V_{DD} = 15\text{ V}, I_D = 2\text{ A},$ $di/dt = 100\text{ A}/\mu\text{S}$		25		nS
Q_{RR}	Reverse recovery charge			13		nC
I_{RRM}	Peak Reverse Recovery Current			1		A

Electrical Characteristics Diagrams

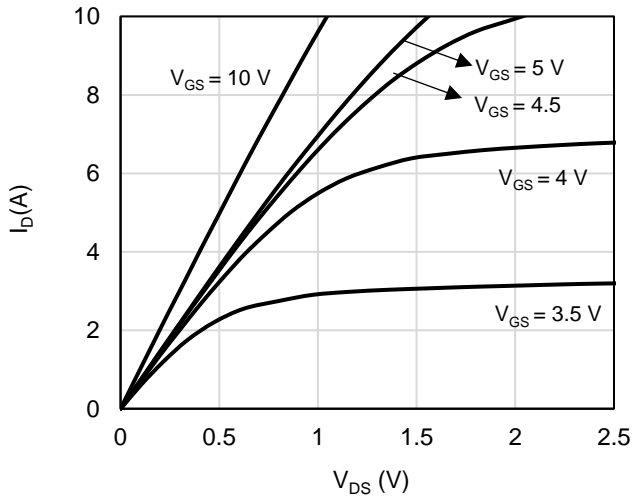


Figure 1: On-Region Characteristics

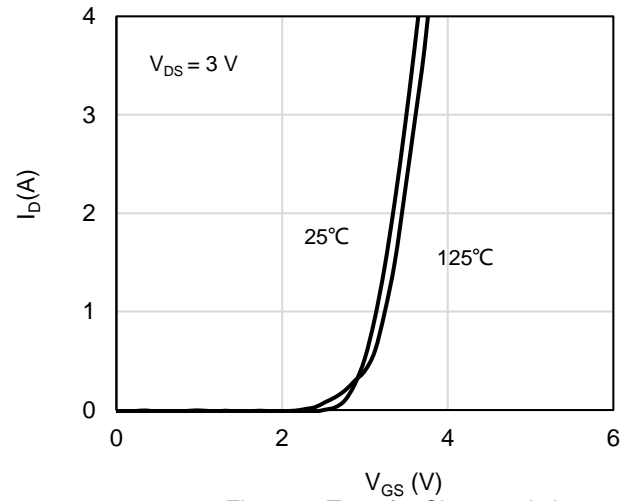


Figure 2: Transfer Characteristics

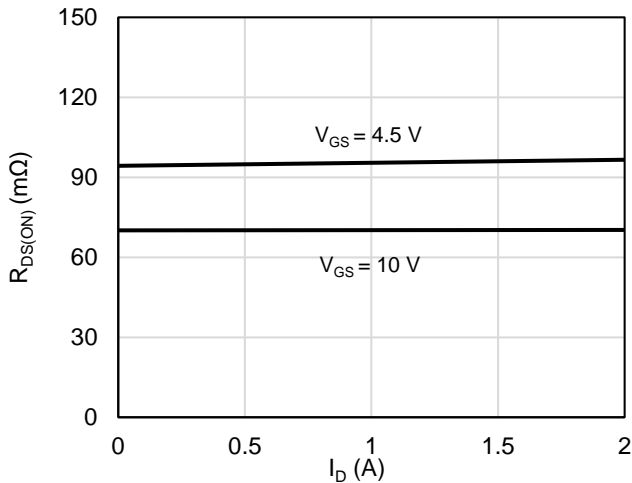


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

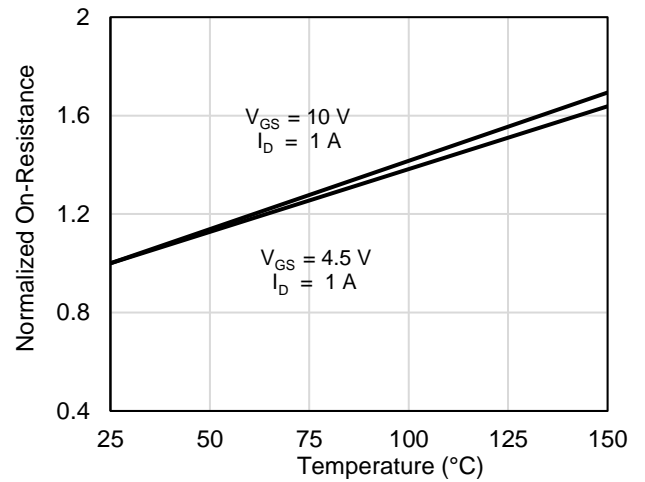


Figure 4: On-Resistance vs. Junction Temperature

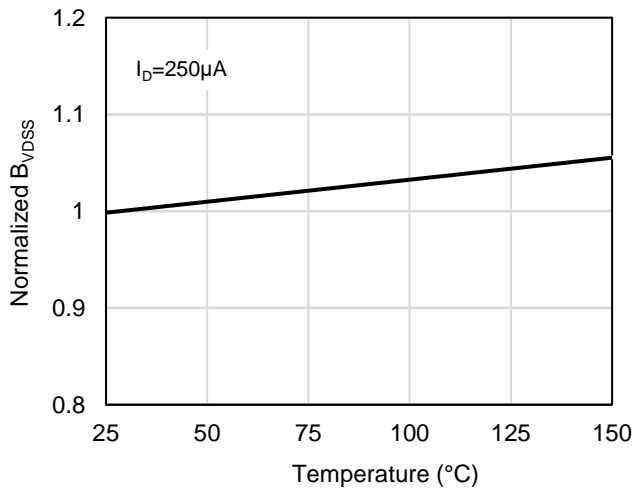


Figure 5: Breakdown Voltage vs. Junction Temperature

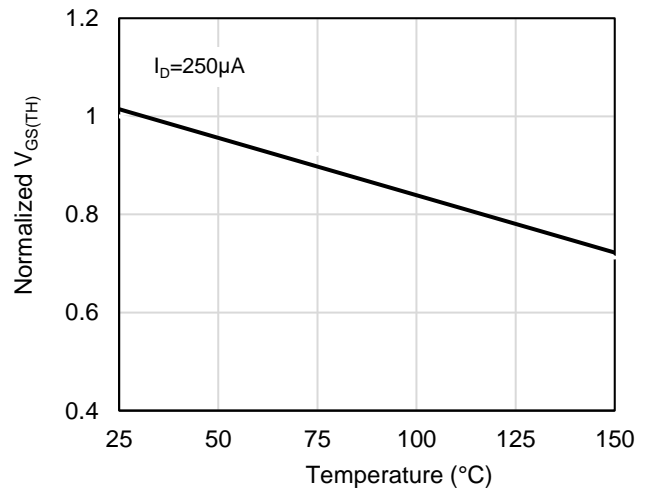
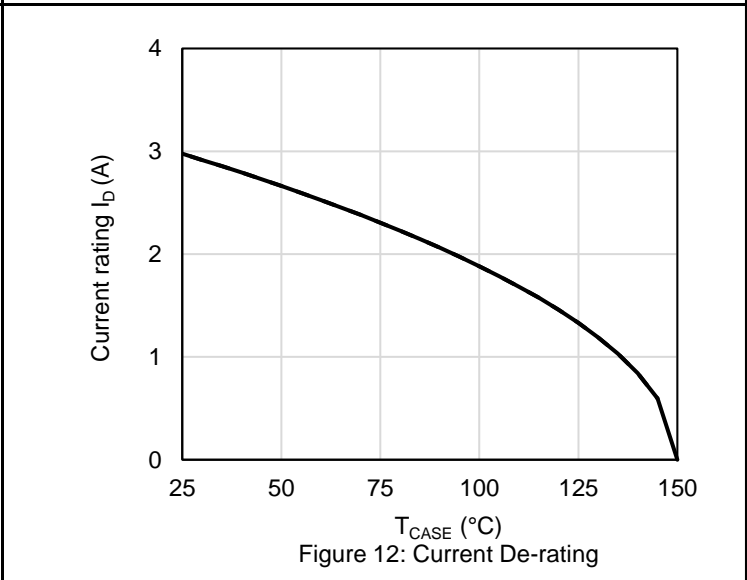
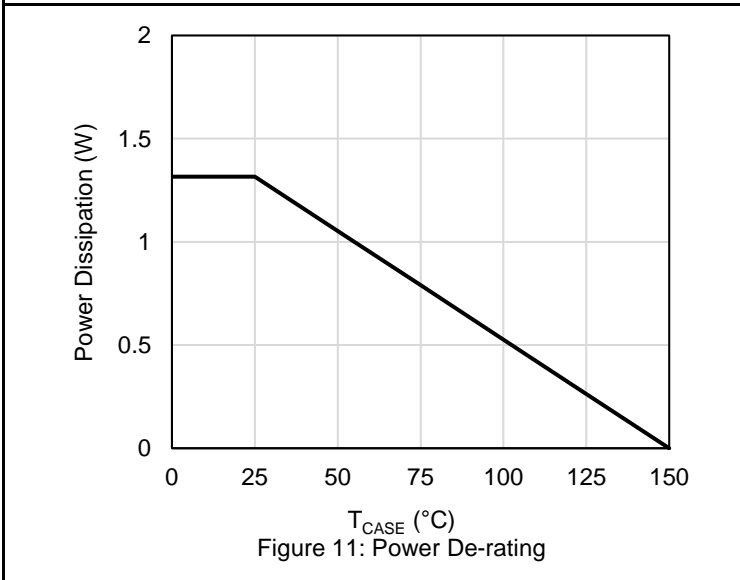
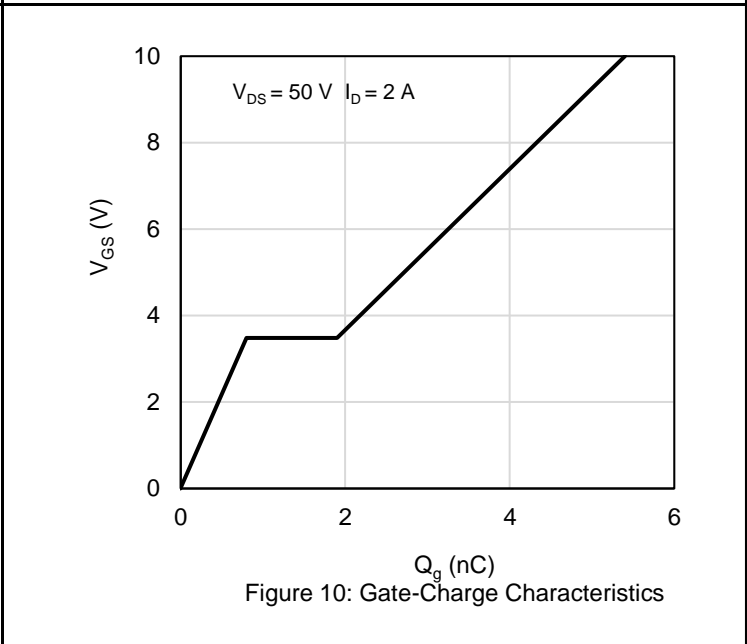
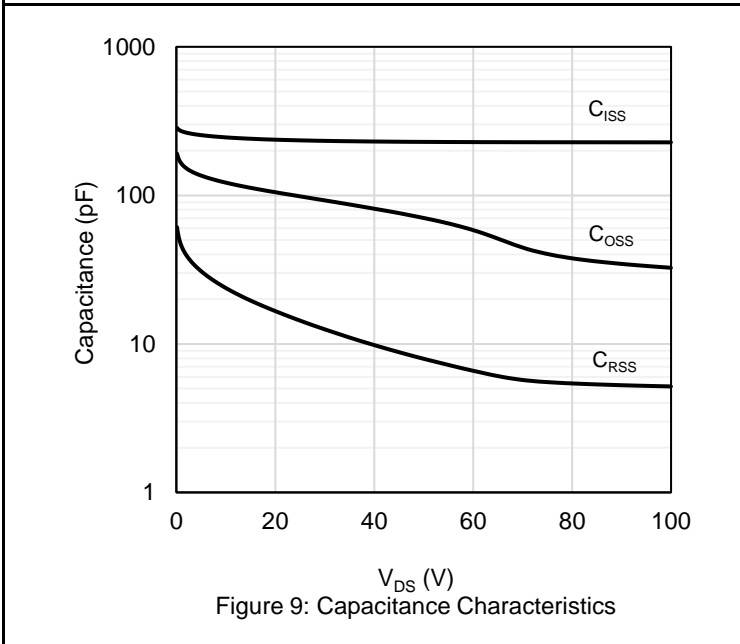
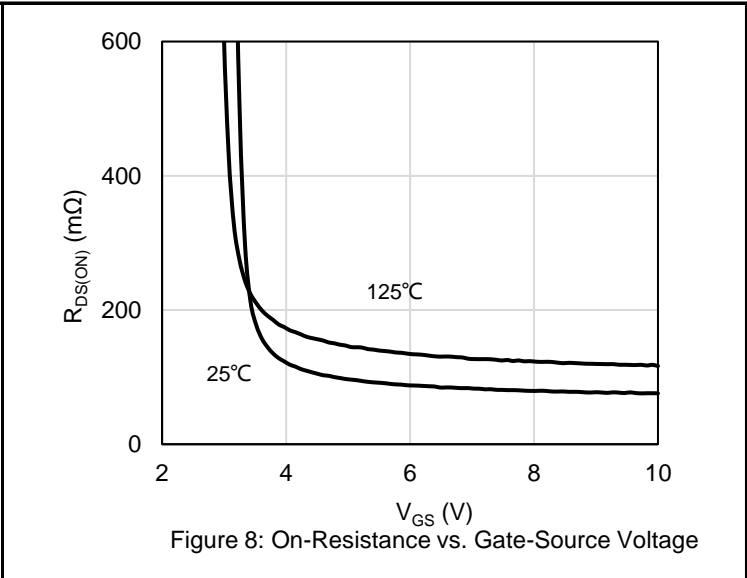
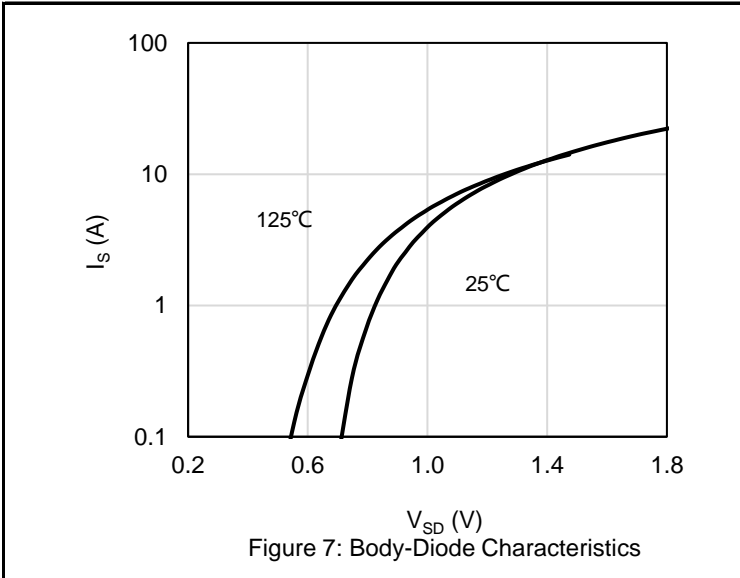
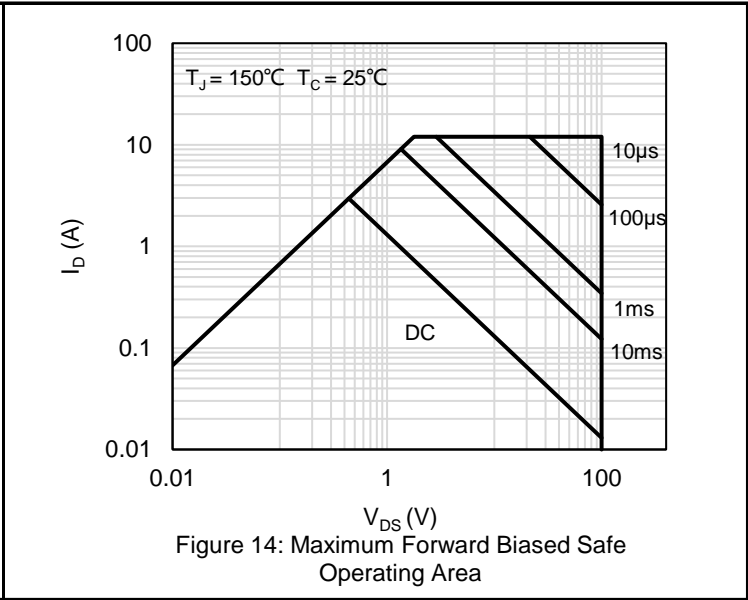
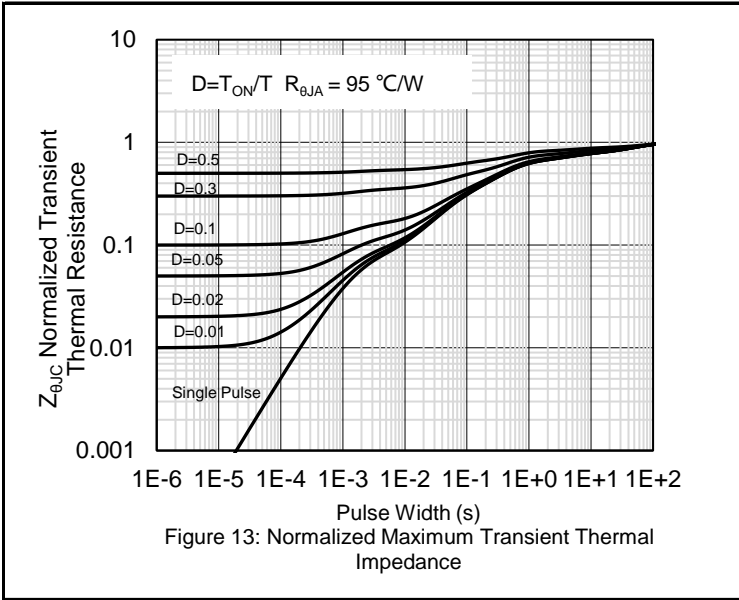


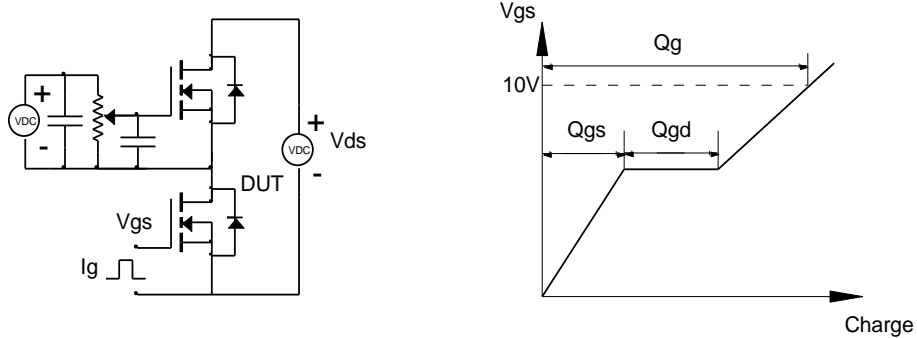
Figure 6: Threshold Voltage vs. Junction Temperature



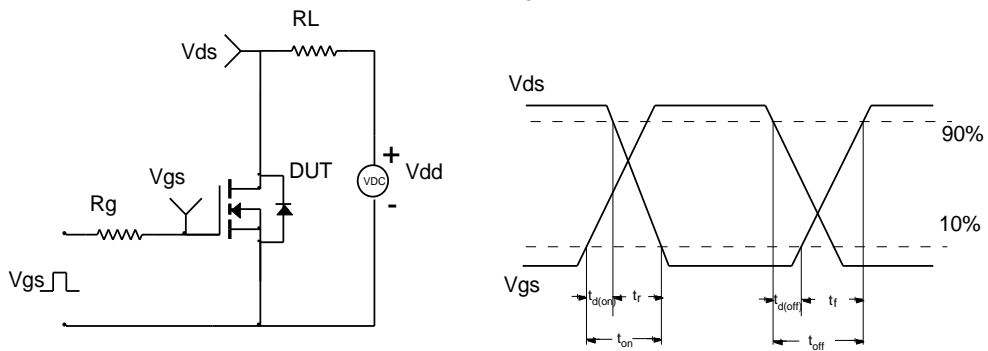


Test Circuit and Waveform

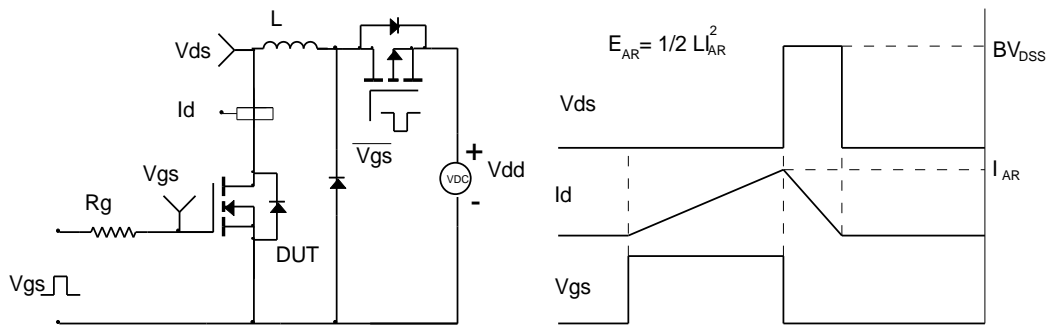
Gate Charge Test Circuit & Waveform



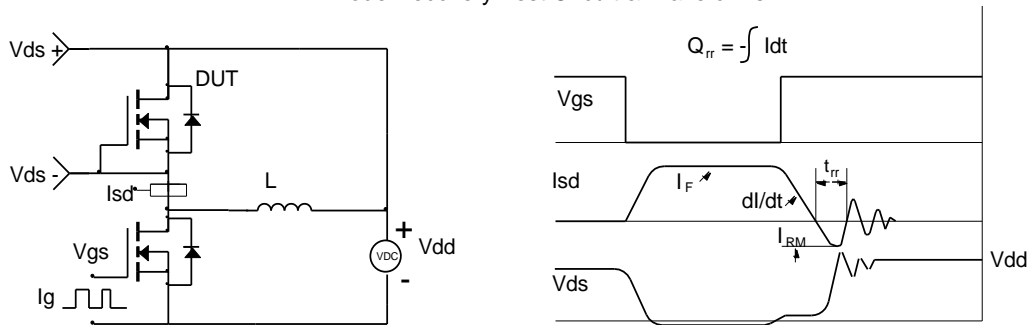
Resistive Switching Test Circuit & Waveforms



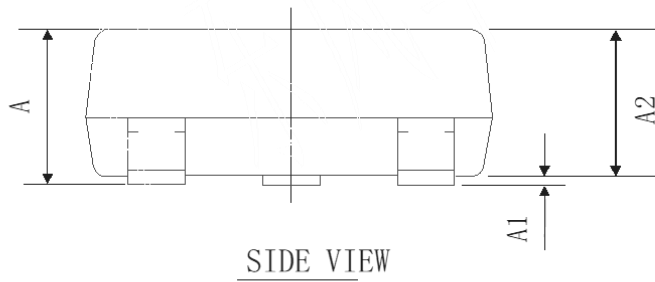
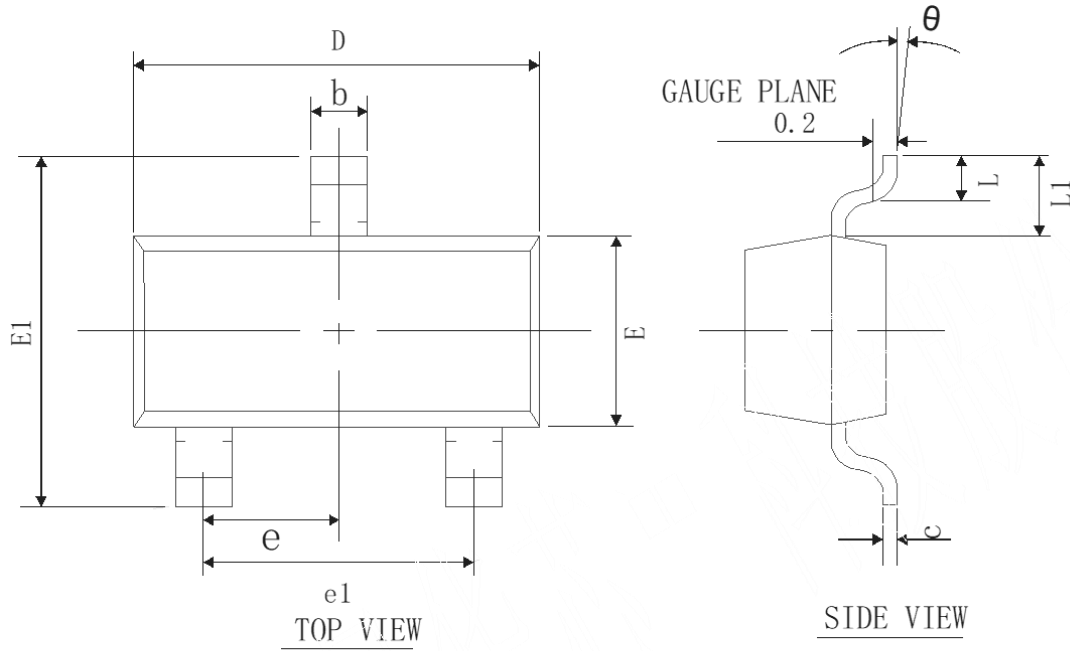
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



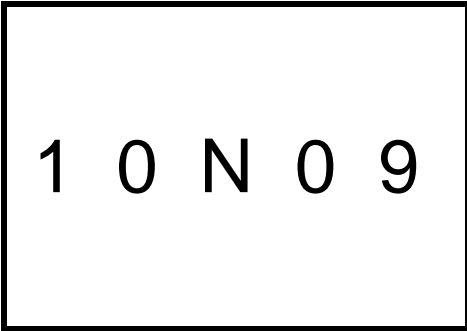
Package Outlines



COMMON DIMENSIONS
(UNITS OF MEASURE=mm)

SYMBOL	MIN	NOM	MAX
A	0.90	1.05	1.20
A1	0.00	0.05	0.10
A2	0.90	1.00	1.10
b	0.30	0.40	0.50
c	0.08	0.10	0.15
D	2.80	2.90	3.00
E	1.20	1.30	1.40
E1	2.30	2.40	2.50
L	0.30	0.40	0.50
θ	0°	5°	10°
L1	0.55 REF		
e	0.95 BSC		
e1	1.90 REF		

Marking Information



Note:

10N09= Product Name Code

Contact ALKAIDSEMI sales for detail information

Revision History

Revision	Release Date	Remark
Rev.1.0	2023/3/8	Initial Release

Disclaimer

The information given in this document describes the independent performance of the product, but similar performance is not guaranteed under other working conditions, and cannot be guaranteed when installed with other products or equipment. To achieve the required performance of the product in actual scenarios, the customer should conduct a complete application test to assess the functionality of the product.

Alkaidsemi assumes no responsibility for equipment failures result from using products at values that exceed the ratings, operating conditions, or other parameters listed in the product specifications.

The product described in this specification is not applicable for aerospace or other applications which requires high reliability. Customers using or selling these products for use in medical, life-saving, or life-sustaining applications do so at their own risk and agree to fully indemnify.

Due to product or technical improvements, the information described or contained herein may be changed without prior notice.